Verification and Validation Report: Measuring Microstructure Changes During Thermal Treatment

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1 Revision History

Date	Name	Notes
Mar 8 2023 Mar 8 2023	Edwin Do Edwin Do	Added usability test results Added Traceability matrices
Mar 8, 2023 Mar 8, 2023	Timothy	Added performance to the Nonfunctional
	Chen	Test Evaluation

2 Symbols, Abbreviations and Acronyms

change capacity to size

symbol	description	
T	Test	
MIN_USER_ACCEPT_RATE	90% - minimum acceptance rate	
$TARGET_{-}TIME$	60 seconds	
INTERACT_TIME	5 seconds	
MAX_MISTAKE	2	
MAX_SIZE	8GB	
$MIN_{-}UPTIME$	30 minutes	
MIN_SAMPLE_RATE	60 samples per second	
TIME_ACCEPTED	1 second	
ACCEPTED_SIGFIG	3 decimals	

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- 3 Functional Requirements Evaluation
- 4 Nonfunctional Requirements Evaluation

In the section

4.1 Usability

The table below shows the results of our usability tests based on the tests in the V&V plan based on the requirements mentioned in the SRS. Each requirement can be traced to multiple unit tests and the usability survey used can be found in the Appendix.

Usability Tests				
Test Requirement	Related Unit Tests	Description	Expected Result	Result
NF-UT1	AF	Completing tasks without additional assistance.	User will be complete tasks successfully	PASS
NF-UT2	AX	Interact with interace to modify parameters.	User will be able to modify the parameters accurately and quickly.	PASS
NF-UT3	AL	Completing all tasks with limited number of mistakes	User will be able to complete all tasks with MAX_MISTAKE	PASS
NF-UT3	AL	Verifying if interacting with the application previously improves ease of use (learnability)	User will be able to complete the tasks more quickly and accurately the second time	PASS
NF-UT5	AS	Verifying how calculations are performed is hidden	User will not know how calculations are performed after doing the set of tasks	PASS
NF-UT6	AS	Verifying appropriate application size upon installation	User will install application onto computer and verify that the application size is less than or equal to MAX_SIZE	PASS

4.2 Performance

The following is the list of Non-functional Test performed on the application to evaluate the performance of the application in respect to the test requirement. Each test will be mapped to unit test that are related to the

corresponding requirement.

Performance Tests				
Test Requirement	Related Unit Tests	Description	Expected Result	Result
NF-PT1	-	Checking the minimum sampling rate of the application.	The sampling rate of the application will be equal or greater than MIN_SAMPLE_RATE	PASS
NF-PT2	-	Checking the time required for parameters to reflect in the application.	The parameters will reflect in the application by within TIME_ACCEPTED	PASS
NF-PT3	-	Checking the significant digits used for calculations and display in the application.	its seen and used in the application is accurate to AC -	PASS
NF-PT4	-	Checking the up-time of the application during and after usage.	The application will have a up-time equal to or more than MIN_UPTIME after the user completes a set of tasks.	PASS

4.3 etc.

5 Comparison to Existing Implementation

This section will not be appropriate for every project.

6 Unit Testing

6.1 Calculation Module

Unit Tests for Calculation Module					
Unit Test ID	Description	Input	Expected Output	Output	Result
UT-C1	Testing the getResistance Method	From Hard-wareInput ADT: Voltage = 5, Current = 1	5.000	5.000	PASS
UT-C1	Testing the getResistance Method	From Hard-wareInput ADT: Voltage = 4 , Current = 0.6	6.667	6.667	PASS
UT-C2	Testing the getResistance Method	From Hard-wareInput ADT: Voltage = -5 , Current = 1	Invalid	Invalid	PASS
UT-C2	Testing the getResistance Method	From Hard-wareInput ADT: Voltage = -4, Current = 0.6	Invalid	Invalid	PASS
UT-C3	Testing the getResistivity Method	Resistance = 3, Area = 2.5, Length = 2	3.750	3.750	PASS
UT-C3	Testing the getResistivity Method	Resistance = 2, Area = 2.8, Length = 1	5.600	5.600	PASS

7 Changes Due to Testing

8 Automated Testing

9 Trace to Requirements

Traceability Matrix to Non Functional Requirements				
Requirement	Requirement(SRS)	Test Requirement	Related Unit Tests	
Type				
Non Functional	NFR-U1	NF-UT1	U	
Non Functional	NFR-U2	NF-UT2	U	
Non Functional	NFR-U3	NF-UT3	U	
Non Functional	NFR-U4	NF-UT4	U	
Non Functional	NFR-U5	NF-UT5	U	
Non Functional	NFR-U6	NF-UT6	U	

Traceability Matrix to Functional Requirements					
Requirement	Requirement(SRS)	Test Requirement	Related Unit Tests		
Type					
Functional	FR1	FR-T1	U		
Functional	FR2	FR-T2	U		
Functional	FR3	FR-T3	U		
Functional	FR4	FR-T4	U		
Functional	FR5	FR-T5	U		
Functional	FR6	FR-T6	U		

10 Trace to Modules

References

Appendix — Reflection

The information in this section will be used to evaluate the team members on the graduate attribute of Lifelong Learning. Please answer the following questions:

- 1.
- 2.